

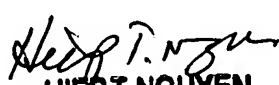
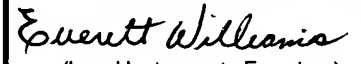


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/616,604	MASSE, WAYNE P.	
	Examiner	Art Unit	
	Hiep T. Nguyen	2187	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
711	173									
INTERNATIONAL CLASSIFICATION										
G	0	6	F	121	02					
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 (Assistant Examiner) (Date)		 HIEP T. NGUYEN PRIMARY EXAMINER (Primary Examiner) (Date) 8/4/05		Total Claims Allowed: 34	
 (Legal Instruments Examiner) (Date) 8.8.05				O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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